

**Notice of References Cited**Application/Control No.  
**09/706,274**Applicant(s)/Patent Under Reexam  
**Arney et al.**Examiner  
**Arlen Soderquist**Art Unit  
**1743**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
<b>A</b>	5,548,224	8/1996	Gabriel et al.	324	765
<b>B</b>					
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<b>N</b>	58-189548	11/1983	JP	Obara et al.	----	----
<b>O</b>	59-4102	1/1984	JP	Tanaka et al.	----	----
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<b>R</b>						
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<b>U</b>	M. L. White Proc. IEEE 1969, 57, 1610-1615.
<b>V</b>	R. G. Manke IEEE Trans. Compon. Hybrids Manuf. Technol. 1981, CHMT-4, 492-498.
<b>W</b>	R. K. Lowry Chem. Abstr. 1982, 97, abstract 64838q.
<b>X</b>	O. Nakagawa et al, J. Electron. Mater. 1984, 13, 231-250.

\* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.

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X	K. M. Takahashi J. Appl. Phys. 1990, 67, 3419-3429.

<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.

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